## Epitaxially Grown Ultra-flat Self-assembling Monolayer of Dendrimers

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## Supplementary Figures

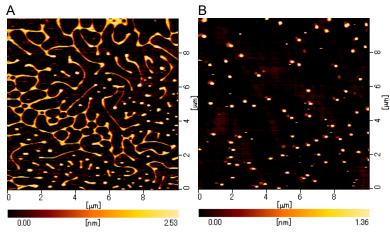
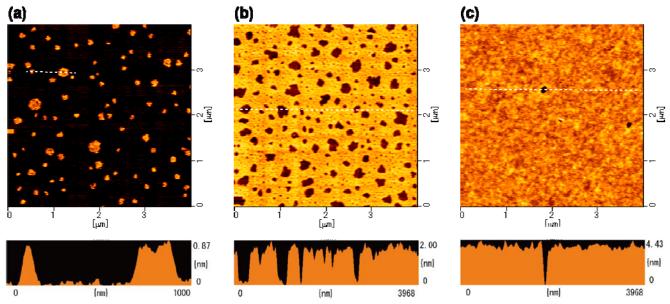


Figure. S1. AFM images of the A) Benzyl ether dendrimer (2), (B) Polyamidoamine dendrimer PAMAMG4OH purchased from Aldrich



**Figure. S2.** AFM topographic images of the SAM of **1** on mica substrates. The fabrication was carried out by a dip-coating method using toluene as the solvent. The concentrations of **1** in the toluene solution were (a) 0.1  $\mu$ mol L<sup>-1</sup>, (b) 10  $\mu$ mol L<sup>-1</sup> and (c) 100  $\mu$ mol L<sup>-1</sup>, respectively. Lower images are the cross-section along the dashed lines shown in the topographic images.

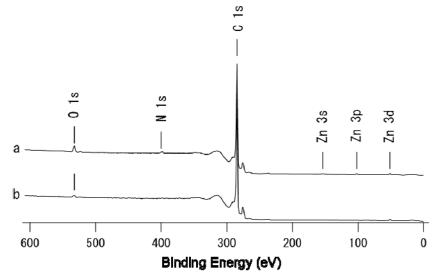
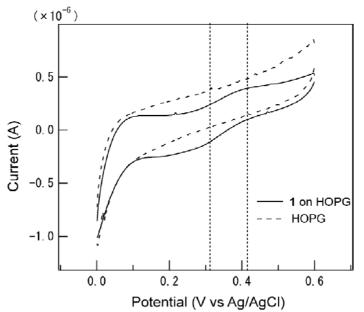
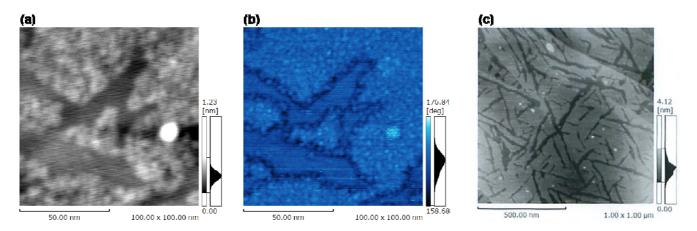


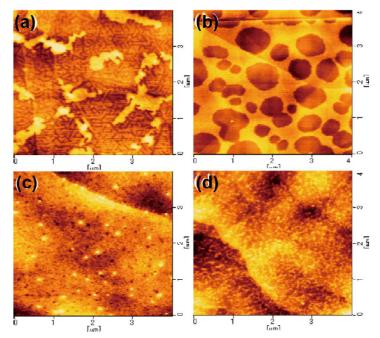
Figure. S3. XPS of HOPG substrates in the presence (a) and the abcence (b) of the SAM.



**Figure. S4.** Cyclic voltammograms of the dendrimer(1)-modified HOPG electrode and a bare HOPG electrode in aqueous solution of KPF<sub>6</sub> (0.1 mol L<sup>-1</sup>).



**Figure. S5.** (a) A higher magnification AFM topographic image and (b) a phase-shift image of the SAM of **1** on an HOPG substrate. (c) The lower magnification AFM topographic image at the same area. The SAM was prepared by dip-coating in a benzene solution of **1** (1  $\mu$ mol L<sup>-1</sup>) in the presence of naphthalene (50  $\mu$ mol L<sup>-1</sup>).



**Figure. S6.** AFM topographic images of the SAM of **1** on HOPG substrates. These SAMs were prepared by different solvents. (a) benzene, (b) chloroform, (c) tetrahydrofuran and (d) toluene.